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EXPEDITED PROCEDURE – EXAMINING GROUP 2857

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Sergey A. Velichko et al.

Examiner: Manuel L. Barbee

Serial No.:

09/834,751

Group Art Unit: 2857

Filed:

April 13, 2001

Docket No.: 303.750US1

Title:

CONCURRENT CONTROL OF SEMICONDUCTOR PARAMETRIC

TESTING

AMENDMENT & RESPONSE UNDER 37 C.F.R. 1.116

Mail Stop RCE Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

In response to the Final Office Action mailed <u>November 7, 2007</u>, please amend the application as follows: